



# GL90P06A8

## GL Silicon P-Channel Power MOSFET

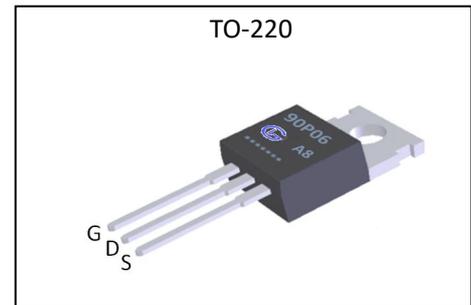
### General Description

The GL90P06A8 uses advanced trench technology and design to provide excellent RDS(ON) with low gate charge. It can be used in a wide variety of applications. The package form is TO-220, which accords with the RoHS standard.

$V_{DSS}$	-60	V
$I_D$	-90	A
$P_D$	200	W
$R_{DS(ON)}$ TYPE	8.5	m $\Omega$

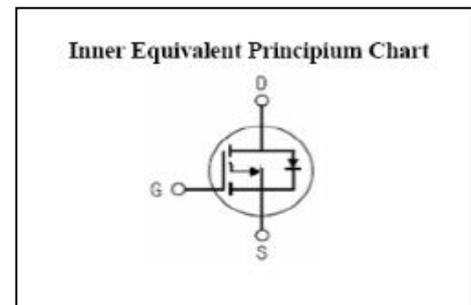
### Features

- Fast Switching
- Low Gate Charge and Rds on
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test



### Applications

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



### Absolute (Tc= 25°C unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	-60	V
$I_D$	Continuous Drain Current	-90	A
	Continuous Drain Current $T_C = 100^\circ\text{C}$	-63	A
$I_{DM}^{a1}$	Pulsed Drain Current	-360	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$dv/dt^{a3}$	Peak Diode Recovery $dv/dt$	5.0	V/ns
$P_D$	Power Dissipation	200	W
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	175, -55 to 175	$^\circ\text{C}$
$T_L$	Maximum Temperature for Soldering	300	$^\circ\text{C}$

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

### Thermal Characteristics

Symbol	Parameter	Typ.	Units
$R_{\theta JC}$	Junction-to-Case	0.75	$^\circ\text{C/W}$
$R_{\theta JA}$	Junction-to-Ambient	62.5	$^\circ\text{C/W}$



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**Electrical Characteristics** (Tc= 25°C unless otherwise specified)

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V <sub>DSS</sub>	Drain to Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA	-60	--	--	V
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Bvdss Temperature Coefficient	I <sub>D</sub> =-250uA, Reference 25°C	--	0.06	--	V/°C
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>DS</sub> =-60, V <sub>GS</sub> =0V, T <sub>a</sub> =25°C	--	--	-1	μA
		V <sub>DS</sub> =-48V, V <sub>GS</sub> =0V, T <sub>a</sub> =125°C	--	--	-250	
I <sub>GSS(F)</sub>	Gate to Source Forward Leakage	V <sub>GS</sub> =+20V	--	--	100	nA
I <sub>GSS(R)</sub>	Gate to Source Reverse Leakage	V <sub>GS</sub> =-20V	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R <sub>DS(ON)1</sub>	Drain-to-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-45A	--	8.5	10	mΩ
R <sub>DS(ON)2</sub>	Drain-to-Source On-Resistance	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-20A	--	9.5	12	mΩ
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-3.0	--	-1.0	V

Pulse width tp ≤ 380μs, δ ≤ 2%

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-45A	--	18	--	S
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-25V f=1.0MHz	--	5800	--	pF
C <sub>oss</sub>	Output Capacitance		--	380	--	
C <sub>rss</sub>	Reverse Transfer Capacitance		--	274	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t <sub>d(ON)</sub>	Turn-on Delay Time	R <sub>L</sub> =1.5Ω, V <sub>DD</sub> =-30V V <sub>GS</sub> =-10V, R <sub>G</sub> =3Ω	--	19	--	ns
t <sub>r</sub>	Rise Time		--	22	--	
t <sub>d(OFF)</sub>	Turn-Off Delay Time		--	57	--	
t <sub>f</sub>	Fall Time		--	38	--	
Q <sub>g</sub>	Total Gate Charge	I <sub>D</sub> =-20.0A, V <sub>DD</sub> =-30V V <sub>GS</sub> =-10V	--	65	--	nC
Q <sub>gs</sub>	Gate to Source Charge		--	11	--	
Q <sub>gd</sub>	Gate to Drain ( "Miller" ) Charge		--	17	--	

### Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current (Body Diode)		--	--	-90	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	-360	A
$V_{SD}$	Diode Forward Voltage	$I_S = -90A, V_{GS} = 0V$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$I_S = -90A, T_j = 25^\circ C$	--	55	--	ns
$Q_{rr}$	Reverse Recovery Charge	$di_f/dt = 100A/us, V_{GS} = 0V$	--	90	--	nC

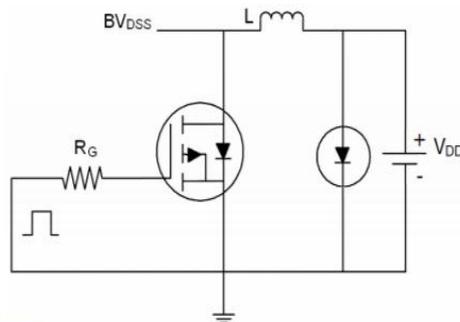
Pulse width  $t_p \leq 380\mu s, \delta \leq 2\%$

<sup>a1</sup>: Repetitive rating; pulse width limited by maximum junction temperature

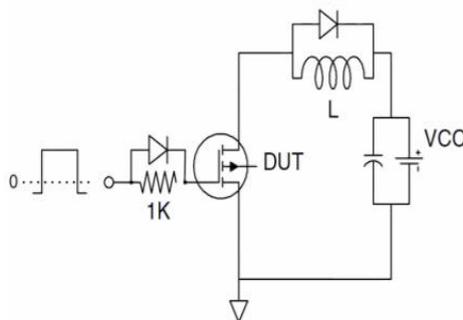
<sup>a3</sup>:  $I_{SD} = -90A, di/dt \leq 100A/us, V_{DD} \leq BV_{DS}, \text{Start } T_j = 25^\circ C$

### Test Circuits

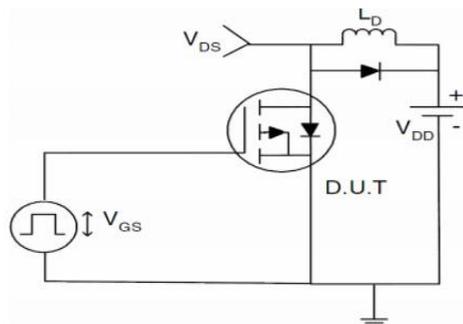
1)  $E_{AS}$  Test Circuit



2) Gate Charge Test Circuit



3) Switch Time Test Circuit

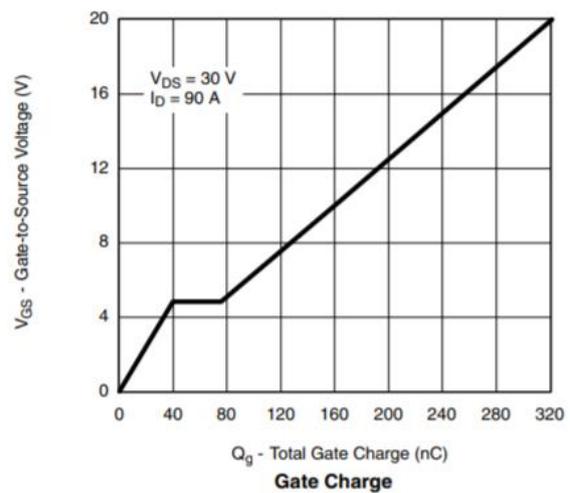
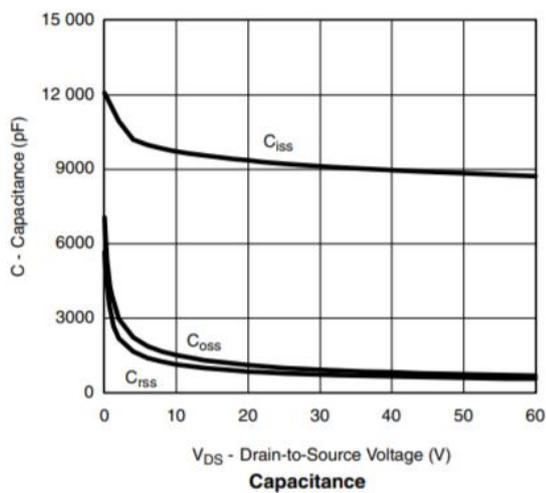
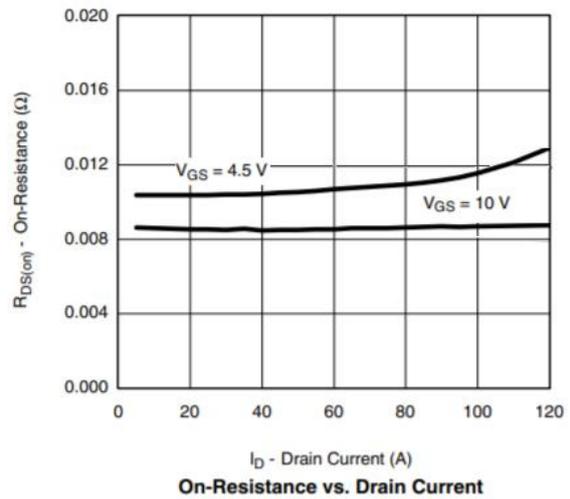
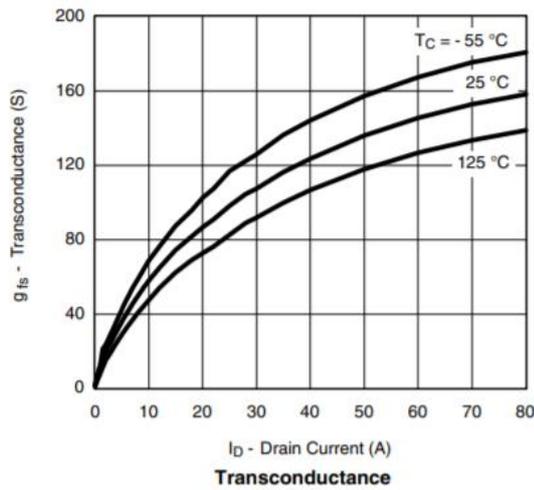
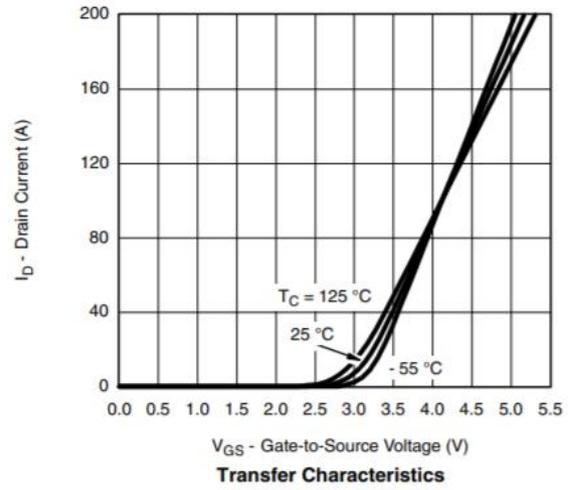
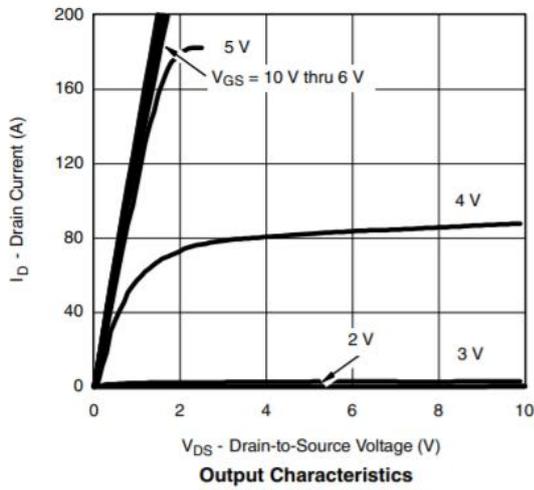




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### Characteristics Curves





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